

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/725,531	LEE, EUGENE M.	
		Examiner	Art Unit	Page 1 of 1
		Jean M. Corrielus	2162	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,556,992	04-2003	Barney et al.	707/6
*	B	US-6,389,418	05-2002	Boyack et al.	707/6
*	C	US-6,330,547	12-2001	Martin, David E.	705/38
*	D	US-6,263,314	07-2001	Donner, Irah H.	705/1
*	E	US-6,175,824	01-2001	Breitzman et al.	705/36R
*	F	US-6,154,725	11-2000	Donner, Irah H.	705/1
*	G	US-2002/0093528	07-2002	Grainger, Jeffry J.	345/738
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Jean O. Lanjouw "How to count patents and value intellectual property: Uses of Patent renewal and application data", National Bureau of economic research. Cambridge, MA, Jul. 1996
	V	B. Zorina Khan, "Legal monopoly: Patent and antitrust litigation in U.S. Manufacturing 1970-1998.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.